Features

- ▶ Ultra-fast response
- Femtometer noise floor
- ▶ *High stability*
- ▶ Closed loop control
- Compact size
- Picometer positioning resolution
- **pico** sensor technology



- High speed, high resolution positioning
- ▶ Metrology
- ► AFM
- ► SPM



Product Description

The Nano-METZ is a compact z-axis nanopositioning system designed for high speed scanning and ultra-low noise characteristics for demanding AFM and metrology applications. The innovative design of the Nano-METZ coupled with our proprietary PicoQ[®] sensor technology yields a resonant frequency of 14.5kHz and a noise floor of 400 femtometers/ \sqrt{Hz} . The result: unparalled speed, response and precision for the most demanding and discerning metrology applications. Related products include the Nano-MET2, Nano-MET3, Nano-MET10 and Nano-MET20 nanopositioning systems.

LabVIEW Compatible **USB** Interfaces



Examples, tutorial, and Nano-Route[®]3D supplied with Nano-Drive" USB LabVIEW interfaces.



Technical Specifications

Range of motion	5 μm
Resolution	0.005 nm
Resonant Frequency	14.5 kHz
Recommended max. load (horizontal)*	0.1 kg
Recommended max. load (vertical)*	0.1 kg
Body Material	. Al or Titanium
Controller	Nano-Drive®
*	

Larger load requirements should be discussed with our engineering staff.



Low Position Noise

